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Kind regards,

Team Nexperia



PBSS302NX

20 V, 5.3 A NPN low V_{CEsat} (BISS) transistor Rev. 02 — 20 November 2009

Product data sheet

Product profile

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT89 (SC-62/TO-243) small and flat lead Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS302PX.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- DC-to-DC conversion
- MOSFET gate driving
- Motor control
- Charging circuits
- Power switches (e.g. motors, fans)

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	20	V
I _C	collector current		-	-	5.3	Α
I_{CM}	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-	10.6	Α
R _{CEsat}	collector-emitter saturation resistance	$I_C = 4 \text{ A};$ $I_B = 200 \text{ mA}$	[1] -	28	40	mΩ

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



2. Pinning information

Table 2. Pinning

Table 2.			
Pin	Description	Simplified outline	Symbol
1	emitter		_
2	collector		2
3	base	3 2 1	3 — 1 sym042

3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
PBSS302NX	SC-62	plastic surface-mounted package; collector pad for good heat transfer; 3 leads	SOT89			

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PBSS302NX	*5C

- [1] * = -: made in Hong Kong
 - * = p: made in Hong Kong
 - * = t: made in Malaysia
 - * = W: made in China

Product data sheet

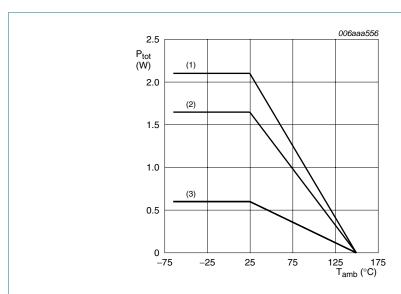
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Limiting values 5.

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	20	V
V_{CEO}	collector-emitter voltage	open base	-	20	V
V_{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current		-	5.3	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	10.6	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[1] -	0.6	W
			[2] -	1.65	W
			[3] _	2.1	W
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm²
- FR4 PCB, standard footprint

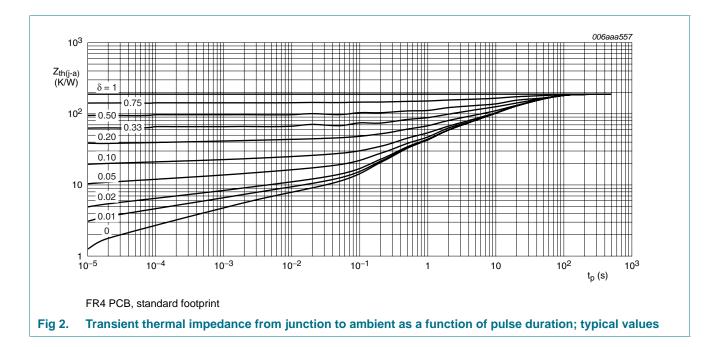
Power derating curves

6. Thermal characteristics

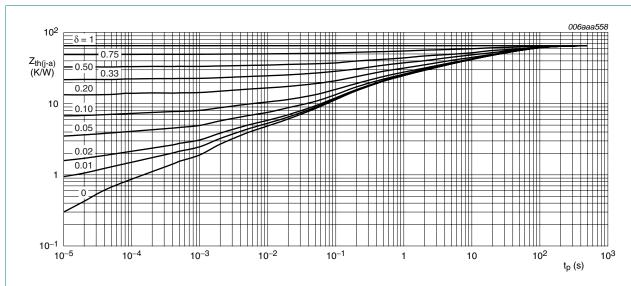
Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> -	-	208	K/W
	junction to ambient		[2]	-	76	K/W
			[3]	-	60	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	20	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- [3] Device mounted on a ceramic PCB, Al₂O₃, standard footprint.

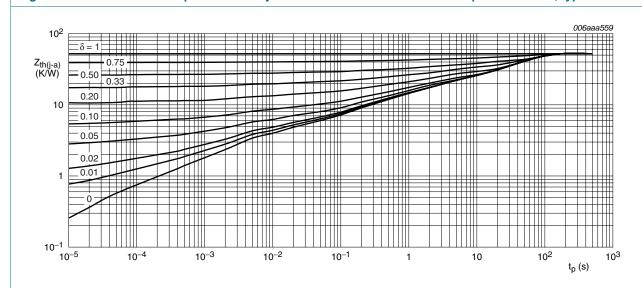


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FR4 PCB, mounting pad for collector 6 cm²

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



Ceramic PCB, Al₂O₃, standard footprint

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

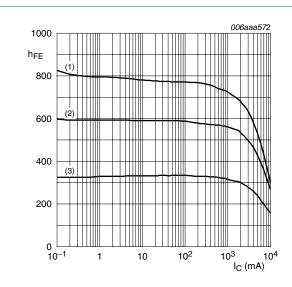
Characteristics

Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
СВО	collector-base cut-off	$V_{CB} = 20 \text{ V}; I_{E} = 0 \text{ A}$		-	-	100	nΑ
	current	$V_{CB} = 20 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 ^{\circ}\text{C}$		-	-	50	μΑ
ЕВО	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$		-	-	100	nA
h _{FE}	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 0.5 \text{ A}$	[1]	300	570	-	
		V _{CE} = 2 V; I _C = 1 A	[1]	300	550	-	
		V _{CE} = 2 V; I _C = 2 A	[1]	250	520	-	
		V _{CE} = 2 V; I _C = 4 A	[1]	200	450	-	
		V _{CE} = 2 V; I _C = 6 A	[1]	200	380	-	
V _{CEsat}	collector-emitter	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	[1]	-	20	25	mV
	saturation voltage	I _C = 1 A; I _B = 50 mA	[1]	-	35	50	mV
		I _C = 1 A; I _B = 10 mA	<u>[1]</u>	-	50	70	mV
		$I_C = 2 \text{ A}; I_B = 40 \text{ mA}$	<u>[1]</u>	-	70	100	mV
		I _C = 4 A; I _B = 200 mA	<u>[1]</u>	-	110	160	mV
		I _C = 4 A; I _B = 400 mA	[1]	-	100	140	mV
		$I_C = 4 \text{ A}; I_B = 40 \text{ mA}$	[1]	-	140	220	mV
		$I_C = 5.3 \text{ A}; I_B = 265 \text{ mA}$	<u>[1]</u>	-	140	200	mV
R _{CEsat}	collector-emitter	$I_C = 4 \text{ A}; I_B = 200 \text{ mA}$	<u>[1]</u>	-	28	40	mΩ
	saturation resistance	$I_C = 4 \text{ A}; I_B = 40 \text{ mA}$	[1]	-	35	55	mΩ
V _{BEsat}	base-emitter	$I_C = 1 A$; $I_B = 100 \text{ mA}$	[1]	-	0.82	0.9	V
	saturation voltage	I _C = 4 A; I _B = 400 mA	[1]	-	0.92	1.05	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1]	-	0.75	0.85	V
t _d	delay time	$V_{CC} = 12.5 \text{ V}; I_C = 3 \text{ A};$		-	15	-	ns
t _r	rise time	$I_{Bon} = 0.15 \text{ A};$		-	40	-	ns
t _{on}	turn-on time	$I_{Boff} = -0.15 \text{ A}$		-	55	-	ns
t _s	storage time			-	270	-	ns
f	fall time			-	85	-	ns
off	turn-off time			-	355	-	ns
f _T	transition frequency	$V_{CE} = 10 \text{ V}; I_{C} = 0.1 \text{ A};$ f = 100 MHz		-	140	-	МН
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	95	150	pF

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$



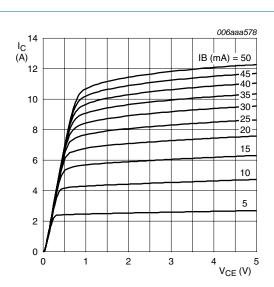
 $V_{CE} = 2 V$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

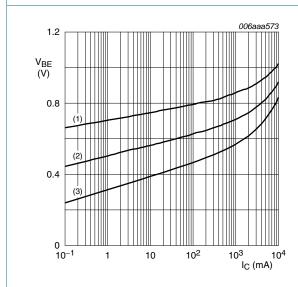
(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$

Fig 6. Collector current as a function of collector-emitter voltage; typical values



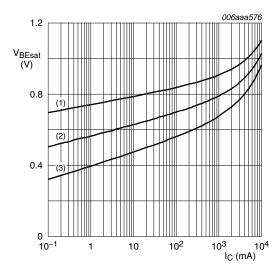
 $V_{CE} = 2 V$

(1) $T_{amb} = -55 \,^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = 100 \, ^{\circ}C$

Base-emitter voltage as a function of collector Fig 7. current; typical values



 $I_{\rm C}/I_{\rm B}=20$

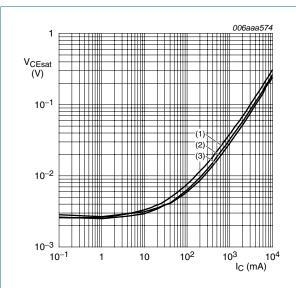
(1) $T_{amb} = -55 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

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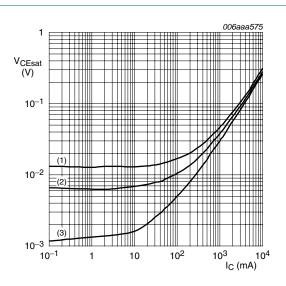
 $I_{\rm C}/I_{\rm B} = 20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Collector-emitter saturation voltage as a Fig 9. function of collector current; typical values



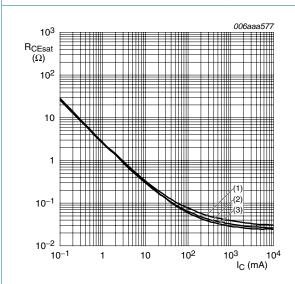
 $T_{amb} = 25 \, ^{\circ}C$

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



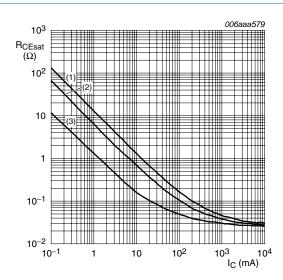
 $I_{\rm C}/I_{\rm B}=20$

(1) $T_{amb} = 100 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



T_{amb} = 25 °C

(1) $I_C/I_B = 100$

(2) $I_C/I_B = 50$

(3) $I_C/I_B = 10$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

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20 V, 5.3 A NPN low V_{CEsat} (BISS) transistor

Test information

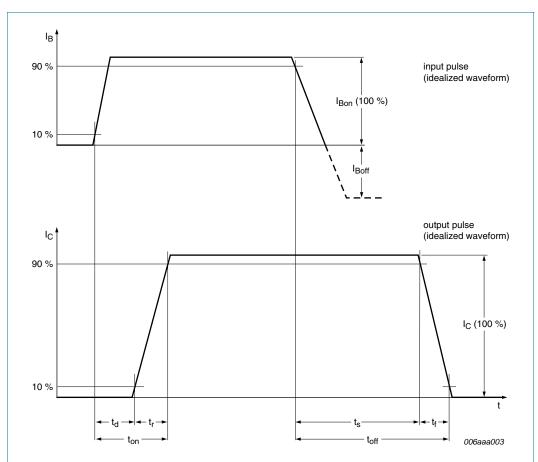
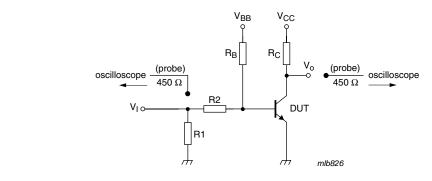


Fig 13. BISS transistor switching time definition



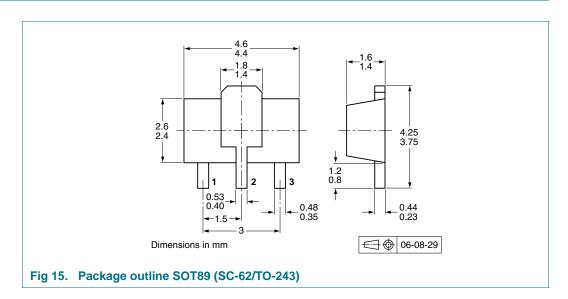
 V_{CC} = 12.5 V; I_{C} = 3 A; I_{Bon} = 0.15 A; I_{Boff} = -0.15 A

Fig 14. Test circuit for switching times

PBSS302NX

20 V, 5.3 A NPN low V_{CEsat} (BISS) transistor

9. Package outline



10. Packing information

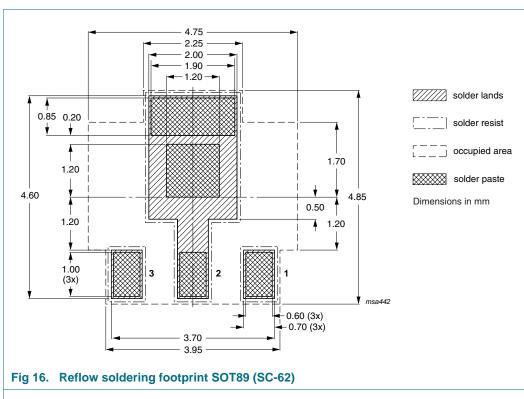
Table 8. Packing methods

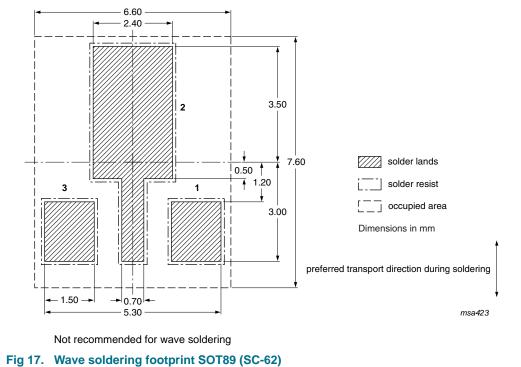
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing	quantity
			1000	4000
PBSS302NX	SOT89	8 mm pitch, 12 mm tape and reel	-115	-135

[1] For further information and the availability of packing methods, see $\underline{\text{Section 15}}$.

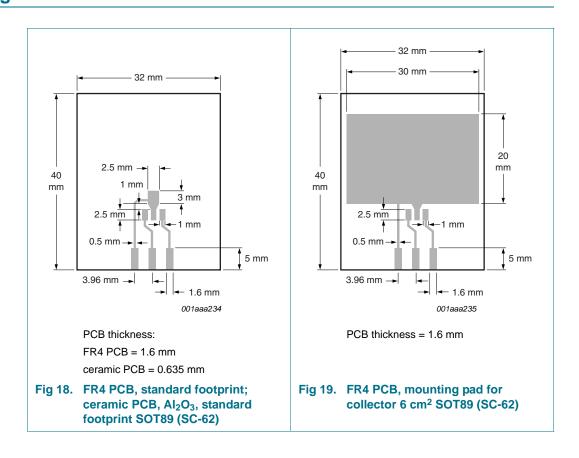
11. Soldering





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12. Mounting





13. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS302NX_2	20091120	Product data sheet	-	PBSS302NX_1
Modifications:		neet was changed to reflect www.legal definitions and disc		
	 Figure 15 "F 	Package outline SOT89 (SC	C-62/TO-243)": updated	
	 Figure 16 "F 	Reflow soldering footprint S	OT89 (SC-62)": updated	I
	 Figure 17 "\ 	Nave soldering footprint SC	OT89 (SC-62)": updated	
PBSS302NX_1	20060824	Product data sheet	-	-

PBSS302NX

20 V, 5.3 A NPN low V_{CEsat} (BISS) transistor

14. Legal information

14.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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